MSKSEMI















ESD

TVS

TSS

MOV

GDT

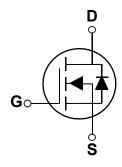
PLED

Brodnet data speet

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SOT-23



Features

- 20V, 4A, $RDS(ON) = 30m\Omega@VGS = 4.5V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
20V	30 m Ω	4A

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	20	V
V _G s	Gate-Source Voltage	±12	V
	Drain Current – Continuous (Tc=25°C)	4	А
lD	Drain Current – Continuous (Tc=100°C)	3.2	А
I _{DM}	Drain Current – Pulsed ¹	16	А
	Power Dissipation (T _C =25°C)	1.56	W
Power Dissipation – Derate above 25°C		0.012	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W

Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.02		V/°C
	Dunin Sauras Laskana Cumant	V _{DS} =20V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS} Drain-Source Leakage Current	Drain-Source Leakage Current	V _{DS} =16V , V _{GS} =0V , T _J =125°C			10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±12V , V _{DS} =0V			±100	nA

On Characteristics

D-2/200	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =4A		30	45	mΩ	
R _{DS(ON)} Static Drain-Source On-Resistance		V _{GS} =2.5V , I _D =3A		45	70	11122	
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA		0.6	1.2	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			2		mV/°C	
gfs	Forward Transconductance	V _{DS} =10V , I _S =2A		4.4		S	

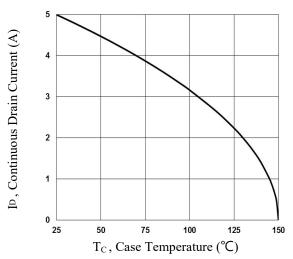
Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			5.8	
Q_{gs}	Gate-Source Charge ^{2, 3}	V _{DS} =10V , V _{GS} =4.5V , I _D =4A		0.6	 nC
Q_{gd}	Gate-Drain Charge ^{2, 3}			1.5	
T _{d(on)}	Turn-On Delay Time ^{2, 3}			2.9	
Tr	Rise Time ^{2, 3}	V_{DD} =10V , V_{GS} =4.5V , R_{G} =25 Ω		8.4	 0
$T_{d(off)}$	Turn-Off Delay Time ^{2, 3}	I _D =1A		19.2	 nS
Tf	Fall Time ^{2,3}			5.6	
Ciss	Input Capacitance			500	
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , F=1MHz		50	 pF
Crss	Reverse Transfer Capacitance			40	

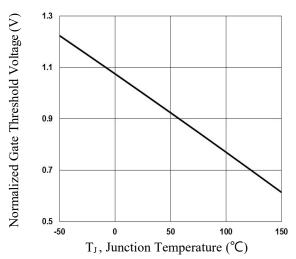
Drain-Source Diode Characteristics and Maximum Ratings						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			4	Α
lsм	Pulsed Source Current				8	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%.
- 3. Essentially independent of operating temperature.



Continuous Drain Current vs. Tc



Normalized Vth vs. TJ

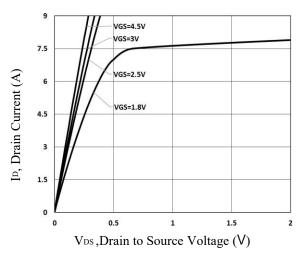
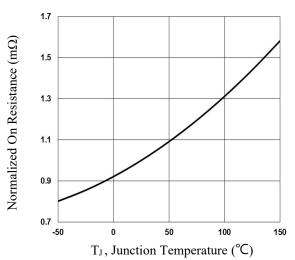
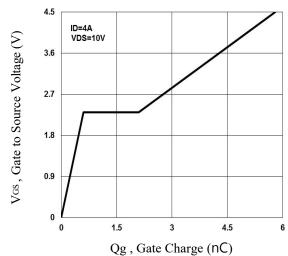


Fig.5 Typical Output Characteristics



Normalized RDSON vs. T_J Fig.2



Gate Charge Waveform

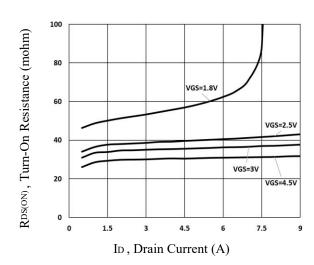


Fig.6 Turn-On Resistance vs. ID



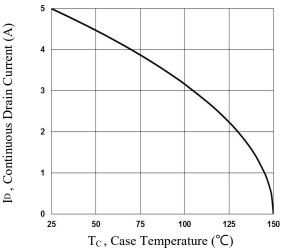


Fig.1 Continuous Drain Current vs. Tc

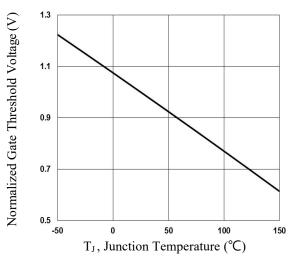


Fig.3 Normalized V_{th} vs. T_J

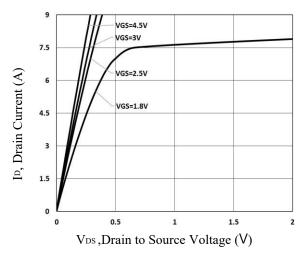
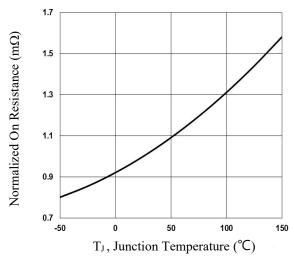
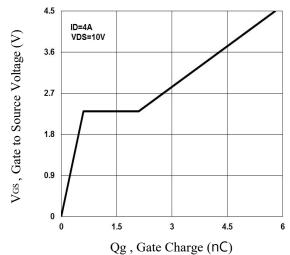


Fig.5 Typical Output Characteristics



Normalized RDSON vs. T_J Fig.2



Gate Charge Waveform

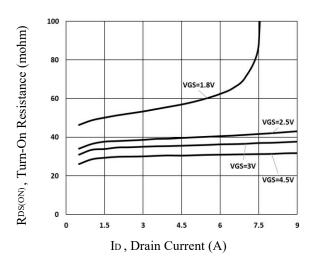
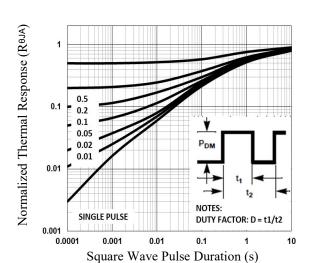


Fig.6 Turn-On Resistance vs. ID





Normalized Transient Impedance

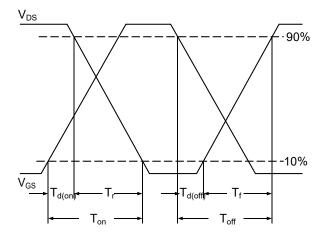


Fig.9 Switching Time Waveform

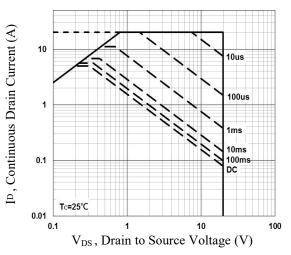


Fig.8 Maximum Safe Operation Area

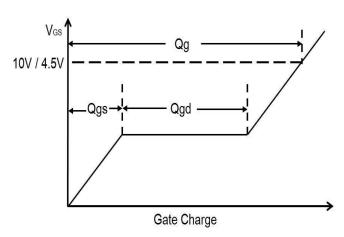
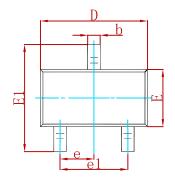
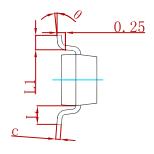
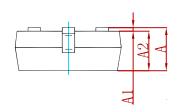


Fig.10 Gate Charge Waveform

PACKAGE MECHANICAL DATA

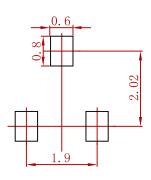






Symbol	Dimensions	Dimensions In Millimeters		s In Inches	
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
Е	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950) TYP	0.037	7 TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022	2 REF	
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
IRLML2502	SOT-23	3000



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